Search Notes

Application/Control No.	Applicant(s)/Patent under
application/Control No.	Reexamination

LIAW, JHON JHY

10/823,822 Examiner

Leigh Marie Garbowski

Art Unit 2825

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
4,19,21	7/20/2006	LMG			
	Subclass	Subclass Date			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST [see strategy]	7/18/2006	LMG	
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